Investigation of the SM2 Module 0 at H8C Testbeam and in the Cosmic Ray Test Facility

Maximilian Herrmann

Ludwig-Maximilians-Universität München - Lehrstuhl Schaile

Muon & NSW Week 10.11.2017, NSW Performance & Testbeam

H8 Testbeam Setup for Tracking





- module fully equipped with 96 APVs
- 1024 strips for each layer were read out by two FEC cards
- two further FEC cards for 28 APVs of tracking telescope: 3 twodimensional GEMs and 2 twodimensional TMMs
 ⇒ 4 EECs read out @ 220 Hz
- acquisition of 25 ns time jitter via TDC (VME)

Centroid Spatial Resolution for Perpendicular Incident



- 5 reference detectors: $\sigma_{\rm track} =$ 70 µm track uncertainty @ SM2
- residual distribution fitted by double Gaussian
 - each Gaussian corrected by the track uncertainty
 - sigmas weighted by integral of the respective Gaussian (*I_i*)

 $\sigma_{\text{centroid}} =$

$$\frac{l_1 \cdot \sqrt{\sigma_1^2 - \sigma_{\mathrm{track}}^2} + l_2 \cdot \sqrt{\sigma_2^2 - \sigma_{\mathrm{track}}^2}}{l_1 + l_2}$$

• resolution : $86\pm5 \mu$ m for eta out @ $U_{amplification} = 580 V$ $U_{drift} = -300 V$

conclusion : tracking works

NSW - SM2 Module 0 @ H8 2017

Investigation of Centroid Resolution



- for both eta layers the same resolution is achieved
 - \Rightarrow below 90 µm
- resolution independent of amplification voltage
- resolution independent of drift voltage
- angular dependence very similar to K.Ntekas ($10 \times 10 \text{ cm}^2$ chambers)



Cluster Reconstruction



- only the cluster with the highest charge is considered (leading cluster, 90% single cluster events) clusters created by noise are avoided
- number of strips in leading cluster increases with angle as expected
- readout PCB differences of Module 0 boards influence heavily the amplification, but not the resolution

charge of leading cluster



Pulse Height



- gas amplification depended on layer
- gas amplification for stereo layers lower

APV Readout and Signal Reconstruction for μTPC Analysis



- single strip APV readout
- APV is sampling charge in 25 ns steps
- charge on strip corresponds to maximum value of APV signal
- ionization time in drift region corresponds to start time of signal \Rightarrow fit with inverse Fermi function: $q(t) = \frac{p_0}{1 + \exp[(t - p_1)/p_2]} + p_3$
 - *p*₀ : maximum charge
 - *p*₁ : turn time (= 50%)
 - *p*₂ : rise time
 - *p*₃ : offset (≈ 0)
- 25 ns time jitter due to 40 MHz sampling recorded via TDC

Single Channel Signal Properties @ 20° , 300 V $U_{ m drift}$



• noise signals:

rise times smaller than 2.5 ns

- very similar signal shapes for all layers
- adjust amplification voltage to avoid saturation of readout channels
- cluster reconstruction: combine neighboring strips with at max 2 missing strips



maximum charge

μTPC Analysis



• angle reconstruction:

 $m_{\rm fit}$: slope µTPC fit

$$\theta = \arctan\left(rac{\mathrm{pitch}}{m_{\mathrm{fit}} \cdot v_{\mathrm{drift}}}
ight)$$

• position reconstruction: t_{fit} : intercept µTPC fit $t_{\text{mid}} = z_{\text{half}} / v_{\text{drift}} + t_{\text{start}}$

$$egin{aligned} & ext{pos} = \ &= rac{z_{ ext{half}} - v_{ ext{drift}} \cdot (t_{ ext{fit}} - t_{ ext{start}})}{v_{ ext{drift}} \cdot m_{ ext{fit}}/ ext{pitch}} \ &= rac{t_{ ext{mid}} - t_{ ext{fit}}}{m_{ ext{fit}}} \cdot ext{pitch} \end{aligned}$$

- determination of $t_{\rm mid}$ with new method
- time jitter correction (40 MHz clock of APV/FEC) works \checkmark
- correction of capacitive coupling between strips \approx 30% \checkmark (LT Spice simulation)

M. Herrmann (LMU Munich)

Preliminary µTPC Results at 20°

angle reconstruction



- run parameter:
 - 590 V amplification voltage
 - 300 V drift voltage
 - muons
 - 20° incident angle
- corrections improve angular and residual distributions by decreasing the width

optimum 30% capacitive coupling

- reconstructed angular distribution peaks at 20° when corrections applied
- very similar results using turn time of Fermi fit, as start time

Time Jitter Correction and Signal Time



- time jitter due to APV sampling in 25 ns steps
- recorded via TDC
- slope of µTPC residual VS time jitter distribution drift time dependent



extrapolated time = turn time - $\log(81)/1.6$ · rise time

Cosmic Ray Test Facility for Module Calibration





- 2D track reconstruction with two Monitored Drift Tube (MDT) chambers
- ullet trigger via scintillator hodoscope with pprox 10 cm resolution in orthogonal direction
- MDT chambers : $2.2 \text{ m} \times 4 \text{ m}$
 - \Rightarrow active area : 9 m², angular acceptance : $\pm 30^{\circ}$
- readout of the full module with six FEC cards @ full 100 Hz μ-rate (tested up to 500 Hz with random trigger)

Average Pulse Height Distribution

- MDT chambers
 ⇒ Y precision coordinate
- scintillators
 ⇒ X coordinate
 coarse segmentation
- HV: 600 V, one sector at 560 V (stereo out)
- homogeneous pulse height (some inefficient spots)
- inefficient regions under investigation





Readout PCB Alignment



- mean of residual to reconstructed track intersection by MDT as function of precision coordinate of the MDT
- reconstruction of:
 - \Rightarrow misalignment of APV
 - adapter boards
 - \Rightarrow shift of readout PCB with

respect ot each other

 \Rightarrow pitch error $\mathcal{O}(100\,\text{nm})$

First Data of SM2 Module 1



cluster charge

setup



- series eta panel 1 doublet
- board 7 of one side read out
- drift voltage : -300 V amplification voltage : 600 V
- coincidence of scintillator trigger from above and below

Conclusions

- centroid analysis shows:
 - $\bullet\,$ resolution for perpendicular tracks is below 90 μm \Rightarrow tracking works $\checkmark\,$
 - resolution behaves as expected \Rightarrow Module works \checkmark
- µTPC analysis:
 - \circ signal properties as expected \checkmark
 - cluster properties as expected \checkmark
 - \circ corrections (jitter, capacitive coupling) work \checkmark
 - \bullet incident angle is reconstructed correctly \checkmark
 - resolution will be further investigated
- investigation in the cosmic ray test facility:
 - \bullet homogeneous pulse height distribution for the full SM2 Module 0 measured \checkmark
 - board alignment will be further investigated

Backup

Measurement Program

view from telescope against beam direction



- scan of a large part of the active area to investigate the efficiency ⇒ dead or noisy areas (for example between the PCBs)
- resolution as function of amplification and drift voltage, as well as incidence angle
- PCB alignment

Readout with Jitter Correction Possibility



Correction due to Capacitive Coupling of Neighboring Strips

charge spread due to capacitive coupling between resistive/readout strips



simulation



implementation

loop strips in cluster
loop timebins from signalstart to maximum
loop neighbors from 1 to 3
neighbor charge - 0.29ⁿ central strip charge
central strip charge + 0.29ⁿ central strip charge

Readout PCB Alignment



NSW - SM2 Module 0 @ H8 2017